

Application/Control No.	Applicant(s)/Patent under Reexamination
10/621,462	TAKASE, HIROSHI
Examiner	Art Unit
Tanh Q. Nguyen .	2182

SEARCHED						
Class	Subclass	Date	Examiner			
710	54,62,64 65,69,70	06/08/05	TQN			
	72-74,105 106,305,306					
725	308,315	J	J			
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)					
	DATE	EXMR			
inventor search - eDAN East No continuity East Search - Results attacked	06/08/05	TQN			
	06/13/05 06/15/05 06/17/05 06/14/65	7			